EPCQ-A Serial Configuration Device Datasheet
1.12. Programming and Configuration File Support ......................................................... 33
1.13. Appendix: SFDP Register Definitions ................................................................. 34
1. EPCQ-A Serial Configuration Device Datasheet

Related Information
AN822: Intel® Configuration Device Migration Guideline

1.1. Supported Devices

Table 1. Supported Intel EPCQ-A Devices

<table>
<thead>
<tr>
<th>Device</th>
<th>Memory Size (bits)</th>
<th>On-Chip Decompression Support</th>
<th>ISP Support</th>
<th>Cascading Support</th>
<th>Reprogrammable</th>
<th>Recommended Operating Voltage (V)</th>
</tr>
</thead>
<tbody>
<tr>
<td>EPCQ4A</td>
<td>4,194,304</td>
<td>No</td>
<td>Yes</td>
<td>No</td>
<td>Yes</td>
<td>3.3</td>
</tr>
<tr>
<td>EPCQ16A</td>
<td>16,777,216</td>
<td>No</td>
<td>Yes</td>
<td>No</td>
<td>Yes</td>
<td>3.3</td>
</tr>
<tr>
<td>EPCQ32A</td>
<td>33,554,432</td>
<td>No</td>
<td>Yes</td>
<td>No</td>
<td>Yes</td>
<td>3.3</td>
</tr>
<tr>
<td>EPCQ64A</td>
<td>67,108,864</td>
<td>No</td>
<td>Yes</td>
<td>No</td>
<td>Yes</td>
<td>3.3</td>
</tr>
<tr>
<td>EPCQ128A</td>
<td>134,217,728</td>
<td>No</td>
<td>Yes</td>
<td>No</td>
<td>Yes</td>
<td>3.3</td>
</tr>
</tbody>
</table>

1.2. Features

EPCQ-A devices offer the following features:

- Serial or quad-serial FPGA configuration in devices that support active serial (AS) x1 or AS x4(1) configuration schemes
- Low cost, low pin count, and non-volatile memory
- 2.7-V to 3.6-V operation
- Available in 8-pin small-outline integrated circuit (SOIC) package for EPCQ4A, EPCQ16A, and EPCQ32A devices
- Available in 16-pin SOIC package for EPCQ64A and EPCQ128A devices
- Reprogrammable memory more than 100,000 program-erase cycles
- Write protection support for memory sectors using status register bits
- Fast read, extended dual input fast read, and extended quad input fast read of the entire memory using a single operation code
- Reprogrammable with an external microprocessor using the SRunner software driver
- In-system programming (ISP) support with the SRunner software driver

(1) AS x4 is not applicable for EPCQ4A.

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*Other names and brands may be claimed as the property of others.
- ISP support with Intel® FPGA Download Cable II, Intel FPGA Download Cable, or Intel FPGA Ethernet Cable
- By default, the memory array is erased and the bits are set to 1
- More than 20-year data retention
- Supports JEDEC standard Serial Flash Discoverable Parameter (SFDP)

### 1.3. Operating Conditions

#### 1.3.1. Absolute Maximum Ratings

Table 2. Absolute Maximum Ratings for EPCQ-A Devices

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Condition</th>
<th>Min</th>
<th>Max</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{CC}$</td>
<td>Supply voltage</td>
<td>With respect to GND</td>
<td>-0.6</td>
<td>4.6</td>
<td>V</td>
</tr>
<tr>
<td>$V_{I}$</td>
<td>DC input voltage</td>
<td>With respect to GND</td>
<td>-0.6</td>
<td>$V_{CC}$+0.4</td>
<td>V</td>
</tr>
<tr>
<td>$T_{STG}$</td>
<td>Storage temperature</td>
<td>No bias</td>
<td>-65</td>
<td>150</td>
<td>°C</td>
</tr>
</tbody>
</table>

#### 1.3.2. Recommended Operating Conditions

Table 3. Recommended Operating Conditions for EPCQ-A Devices

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Condition</th>
<th>Min</th>
<th>Max</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{CC}$</td>
<td>Supply voltage</td>
<td>(2)</td>
<td>2.7</td>
<td>3.6</td>
<td>V</td>
</tr>
<tr>
<td>$T_{A}$</td>
<td>Ambient temperature, Operating</td>
<td>For industrial use</td>
<td>-40</td>
<td>85</td>
<td>°C</td>
</tr>
</tbody>
</table>

#### 1.3.3. DC Operating Conditions

Table 4. DC Operating Conditions for EPCQ-A Devices

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Condition</th>
<th>Min</th>
<th>Max</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{IH}$</td>
<td>High-level input voltage</td>
<td>—</td>
<td>0.7 x $V_{CC}$</td>
<td>$V_{CC}$ + 0.4</td>
<td>V</td>
</tr>
<tr>
<td>$V_{IL}$</td>
<td>Low-level input voltage</td>
<td>—</td>
<td>-0.5</td>
<td>0.3 x $V_{CC}$</td>
<td>V</td>
</tr>
<tr>
<td>$V_{OH}$</td>
<td>High-level output voltage</td>
<td>$I_{OH} = -100$ µA</td>
<td>$V_{CC}$ - 0.2</td>
<td>—</td>
<td>V</td>
</tr>
<tr>
<td>$V_{OL}$</td>
<td>Low-level output voltage for EPCQ4A</td>
<td>$I_{OL} = 100$ µA</td>
<td>—</td>
<td>0.4</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td>Low-level output voltage for EPCQ16A, EPCQ32A, EPCQ64A, and EPCQ128A</td>
<td>—</td>
<td>—</td>
<td>0.2</td>
<td>V</td>
</tr>
<tr>
<td>$I_{I}$</td>
<td>Input leakage current</td>
<td>$V_{I} = V_{CC}$ or GND</td>
<td>-2</td>
<td>2</td>
<td>µA</td>
</tr>
<tr>
<td>$I_{OZ}$</td>
<td>Tri-state output off-state current</td>
<td>$V_{O} = V_{CC}$ or GND</td>
<td>-2</td>
<td>2</td>
<td>µA</td>
</tr>
</tbody>
</table>

(2) $V_{CC}$ voltage during a Read operation can operate across the min and max range but should not exceed ±10% of the programming (erase/write) voltage.
1.3.4. AC Measurement Conditions

Table 5. AC Measurement Conditions for EPCQ-A Devices

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Min</th>
<th>Max</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>C_L</td>
<td>Load Capacitance</td>
<td>0</td>
<td>30</td>
<td>pF</td>
</tr>
<tr>
<td>T_R, T_F</td>
<td>Input Rise and Fall Times</td>
<td>0.1 V_CC to 0.9 V_CC</td>
<td>5 V</td>
<td>ns</td>
</tr>
<tr>
<td>V_IN</td>
<td>Input Pulse Voltages</td>
<td>0.3 V_CC to 0.7 V_CC</td>
<td>0.5 V_CC to 0.5 V_CC</td>
<td>V</td>
</tr>
<tr>
<td>V_OUT</td>
<td>Output Timing Reference Voltages</td>
<td>0.5 V_CC to 0.5 V_CC</td>
<td>V</td>
<td></td>
</tr>
</tbody>
</table>

Figure 1. AC Measurement I/O Waveform

<table>
<thead>
<tr>
<th>Input Levels</th>
<th>Input and Output Timing Reference Levels</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.1 V_CC</td>
<td>0 V_CC</td>
</tr>
<tr>
<td>0.9 V_CC</td>
<td>0.5 V_CC</td>
</tr>
</tbody>
</table>

1.3.5. ICC Supply Current

Table 6. ICC Supply Current AC Measurement

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Condition</th>
<th>Min</th>
<th>Max</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>I_CCO</td>
<td>V_CC supply current for EPCQ4A, EPCQ16A, EPCQ32A, and EPCQ64A</td>
<td>Standby</td>
<td>10</td>
<td>50</td>
<td>µA µA</td>
</tr>
<tr>
<td></td>
<td>V_CC supply current for EPCQ128A</td>
<td></td>
<td>60</td>
<td>50</td>
<td>µA µA</td>
</tr>
<tr>
<td>I_CCI</td>
<td>V_CC supply current for EPCQ4A</td>
<td>During active power mode</td>
<td>1</td>
<td>5</td>
<td>mA</td>
</tr>
<tr>
<td></td>
<td>V_CC supply current for EPCQ16A, EPCQ32A, and EPCQ64A</td>
<td></td>
<td>1</td>
<td>15</td>
<td>mA</td>
</tr>
<tr>
<td></td>
<td>V_CC supply current for EPCQ128A</td>
<td></td>
<td>1</td>
<td>20</td>
<td>mA</td>
</tr>
</tbody>
</table>

1.3.6. Capacitance

Table 7. Capacitance for EPCQ-A Devices

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Condition</th>
<th>Min</th>
<th>Max</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>C_IN</td>
<td>Input pin capacitance</td>
<td>Vin = 0 V</td>
<td>—</td>
<td>6</td>
<td>pF</td>
</tr>
<tr>
<td>C_OUT</td>
<td>Output pin capacitance</td>
<td>Vout = 0 V</td>
<td>—</td>
<td>8</td>
<td>pF</td>
</tr>
</tbody>
</table>
1.4. Pin Information

1.4.1. Pin-Out Diagram for EPCQ4A, EPCQ16A and EPCQ32A Devices

Figure 2. AS x1 and AS x4 Pin-Out Diagrams for EPCQ4A, EPCQ16A, and EPCQ32A Devices

Note: EPCQ4A supports AS x1 only.

1.4.2. Pin-Out Diagram for EPCQ64A and EPCQ128A Devices

Figure 3. AS x1 and AS x4 Pin-Out Diagrams for EPCQ64A and EPCQ128A Devices

Notes:
N.C. pins must be left unconnected.

There is an internal pull-up resistor for the dedicated nRESET pin. If the reset function is not needed, connect this pin to Vcc or leave it unconnected.
## 1.4.3. EPCQ-A Device Pin Description

### Table 8. EPCQ-A Device Pin Description

<table>
<thead>
<tr>
<th>Pin Name</th>
<th>AS x1 Pin-Out Diagram</th>
<th>AS x4 Pin-Out Diagram</th>
<th>Pin Type</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>Pin Number in 8-Pin SOIC Package</td>
<td>Pin Number in 16-Pin SOIC Package</td>
<td></td>
<td></td>
</tr>
<tr>
<td>DATA0</td>
<td>5 15</td>
<td>5 15</td>
<td>I/O</td>
<td>For AS x1 mode, use this pin as an input signal pin to write or program the EPCQ-A device. During write or program operations, data are latched at rising edges of the DCLK signal. This pin is equivalent to the ASDI pin in EPCS devices. For AS x4 mode, use this pin as an I/O signal pin. During write or program operations, this pin acts as an input pin that serially transfers data into the EPCQ-A device. The data are latched at rising edges of the DCLK signal. During read or configuration operations, this pin acts as an output signal pin that serially transfers data out of the EPCQ-A device to the FPGA. The data is shifted out at falling edges of the DCLK signal. During the quad input fast write bytes operation, this pin acts as an input pin that serially transfers data into the EPCQ-A device. The data is latched at rising edges of the DCLK signal. During extended dual input fast read or extended quad input fast read operations, this pin acts as an output signal pin that serially transfers data out of the EPCQ-A device to the FPGA. The data is shifted out at falling edges of the DCLK signal.</td>
</tr>
<tr>
<td>DATA1</td>
<td>2 8</td>
<td>2 8</td>
<td>I/O</td>
<td>For AS x1 and x4 modes, use this pin as an output signal pin that serially transfers data out of the EPCQ-A device to the FPGA during read or configuration operations. The transition of the signal is at falling edges of the DCLK signal. This pin is equivalent to the DATA pin in EPCS devices. During the quad input fast write bytes operation, this pin acts as an input signal pin that serially transfers data into the EPCQ-A device. The data is latched at rising edges of the DCLK signal. During extended quad input fast read operations, this pin acts as an output signal pin that serially transfers data out of the EPCQ-A device to the FPGA. The data is shifted out at falling edges of the DCLK signal. During read, configuration, or program operations, you can enable the EPCQ-A device by pulling the nCS signal low.</td>
</tr>
<tr>
<td>DATA2</td>
<td>— —</td>
<td>3 9</td>
<td>I/O</td>
<td>For AS x1 mode, this pin must connect to VCC. For AS x4 mode, use this pin as an output signal that serially transfers data out of the EPCQ-A device to the FPGA during read or configuration operations. The transition of the signal is at falling edges of the DCLK signal. During the extended quad input fast read operation, this pin acts as an output signal pin that serially transfers data out of the EPCQ-A device to the FPGA. The data is shifted out at falling edges of the DCLK signal.</td>
</tr>
</tbody>
</table>

*continued...*
<table>
<thead>
<tr>
<th>Pin Name</th>
<th>AS x1 Pin-Out Diagram</th>
<th>AS x4 Pin-Out Diagram</th>
<th>Pin Type</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>Pin Number in 8-Pin SOIC Package</td>
<td>Pin Number in 16-Pin SOIC Package</td>
<td>Pin Number in 8-Pin SOIC Package</td>
<td>Pin Number in 16-Pin SOIC Package</td>
</tr>
<tr>
<td>DATA3</td>
<td>—</td>
<td>—</td>
<td>7</td>
<td>1</td>
</tr>
<tr>
<td>nCS</td>
<td>1</td>
<td>7</td>
<td>1</td>
<td>7</td>
</tr>
<tr>
<td>DCLK</td>
<td>6</td>
<td>16</td>
<td>6</td>
<td>16</td>
</tr>
<tr>
<td>nRESET</td>
<td>—</td>
<td>3</td>
<td>—</td>
<td>3</td>
</tr>
<tr>
<td>V\textsubscript{CC}</td>
<td>8</td>
<td>2</td>
<td>8</td>
<td>2</td>
</tr>
<tr>
<td>GND</td>
<td>4</td>
<td>10</td>
<td>4</td>
<td>10</td>
</tr>
</tbody>
</table>

### 1.5. Device Package and Ordering Code

#### 1.5.1. Package

The EPCQ4A, EPCQ16A, and EPCQ32A devices are available in 8-pin SOIC packages. The EPCQ64A and EPCQ128A devices are available in 16-pin SOIC packages.
1.5.2. Ordering Code

Table 9.  EPCQ-A Device Ordering Codes

<table>
<thead>
<tr>
<th>Device</th>
<th>Ordering Code(3)</th>
</tr>
</thead>
<tbody>
<tr>
<td>EPCQ4A</td>
<td>EPCQ4ASI8N</td>
</tr>
<tr>
<td>EPCQ16A</td>
<td>EPCQ16ASI8N</td>
</tr>
<tr>
<td>EPCQ32A</td>
<td>EPCQ32ASI8N</td>
</tr>
<tr>
<td>EPCQ64A</td>
<td>EPCQ64ASI16N</td>
</tr>
<tr>
<td>EPCQ128A</td>
<td>EPCQ128ASI16N</td>
</tr>
</tbody>
</table>

1.6. Memory Array Organization

Table 10.  Supported Memory Array Organization in EPCQ-A Devices

<table>
<thead>
<tr>
<th>Details</th>
<th>EPCQ4A</th>
<th>EPCQ16A</th>
<th>EPCQ32A</th>
<th>EPCQ64A</th>
<th>EPCQ128A</th>
</tr>
</thead>
<tbody>
<tr>
<td>Bytes</td>
<td>524,288 bytes [4 megabits (Mb)]</td>
<td>2,097,152 bytes [16 Mb]</td>
<td>4,194,304 bytes [32 Mb]</td>
<td>8,388,608 bytes [64 Mb]</td>
<td>16,777,216 bytes (128 Mb)</td>
</tr>
<tr>
<td>Number of sectors</td>
<td>8</td>
<td>32</td>
<td>64</td>
<td>128</td>
<td>256</td>
</tr>
<tr>
<td>Bytes per sector</td>
<td>65,536 bytes [512 kilobits (Kb)]</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Total numbers of subsectors (4)</td>
<td>128</td>
<td>512</td>
<td>1,024</td>
<td>2,048</td>
<td>4,096</td>
</tr>
<tr>
<td>Bytes per subsector</td>
<td>4,096 bytes (32 Kb)</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Pages per sector</td>
<td>256</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Total number of pages</td>
<td>2,048</td>
<td>8,192</td>
<td>16,384</td>
<td>32,768</td>
<td>65,536</td>
</tr>
<tr>
<td>Bytes per page</td>
<td>256 bytes</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

1.6.1. Address Range for EPCQ4A

Table 11.  Address Range for Sectors 7..0 and Subsectors 127..0 in EPCQ4A Devices

<table>
<thead>
<tr>
<th>Sector</th>
<th>Subsector</th>
<th>Address Range (Byte Addresses in HEX)</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td></td>
<td>Start</td>
</tr>
<tr>
<td>7</td>
<td>127</td>
<td>7F000</td>
</tr>
<tr>
<td></td>
<td>126</td>
<td>7E000</td>
</tr>
<tr>
<td></td>
<td>...</td>
<td>...</td>
</tr>
<tr>
<td></td>
<td>114</td>
<td>72000</td>
</tr>
<tr>
<td></td>
<td>113</td>
<td>71000</td>
</tr>
</tbody>
</table>

(3)  N indicates that the device is lead free.

(4)  Every sector is further divided into 16 subsectors with 4 KB of memory. Therefore, there are 128 (8 x 16) subsectors for the EPCQ4A device, 512 (32 x 16) subsectors for the EPCQ16A device, 1,024 (64 x 16) subsectors for the EPCQ32A device, 2,048 (128 x 16) subsectors for the EPCQ64A device, and 4,096 (256 x 16) subsectors for the EPCQ128A device.
### Address Range for EPCQ16A

**Table 12. Address Range for Sectors 31..0 and Subsectors 511..0 in EPCQ16A Devices**

<table>
<thead>
<tr>
<th>Sector</th>
<th>Subsector</th>
<th>Address Range (Byte Addresses in HEX)</th>
</tr>
</thead>
<tbody>
<tr>
<td>31</td>
<td>511</td>
<td>1FF000 - 1FFFFF</td>
</tr>
<tr>
<td></td>
<td>510</td>
<td>1FE000 - 1FEFFF</td>
</tr>
<tr>
<td></td>
<td>498</td>
<td>.</td>
</tr>
<tr>
<td></td>
<td>497</td>
<td>1F2000 - 1F2FFF</td>
</tr>
<tr>
<td></td>
<td>496</td>
<td>1F0000 - 1F0FFF</td>
</tr>
<tr>
<td>30</td>
<td>495</td>
<td>1EF000 - 1EFFF</td>
</tr>
<tr>
<td></td>
<td>494</td>
<td>1EE000 - 1EEFFF</td>
</tr>
<tr>
<td></td>
<td>482</td>
<td>.</td>
</tr>
<tr>
<td></td>
<td>481</td>
<td>1E1000 - 1E1FFF</td>
</tr>
</tbody>
</table>

**continued...**
### 1.6.3. Address Range for EPCQ32A

#### Table 13. Address Range for Sectors 63..0 and Subsectors 1023..0 in EPCQ32A Devices

<table>
<thead>
<tr>
<th>Sector</th>
<th>Subsector</th>
<th>Address Range (Byte Addresses in HEX)</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td></td>
<td>Start</td>
</tr>
<tr>
<td>63</td>
<td>1023</td>
<td>3FF000</td>
</tr>
<tr>
<td></td>
<td>1022</td>
<td>3FE000</td>
</tr>
<tr>
<td></td>
<td>.</td>
<td>.</td>
</tr>
<tr>
<td></td>
<td>1010</td>
<td>3F2000</td>
</tr>
<tr>
<td></td>
<td>1009</td>
<td>3F1000</td>
</tr>
<tr>
<td></td>
<td>1008</td>
<td>3F0000</td>
</tr>
<tr>
<td>62</td>
<td>1007</td>
<td>3F0000</td>
</tr>
<tr>
<td></td>
<td>1006</td>
<td>3EE000</td>
</tr>
<tr>
<td></td>
<td>.</td>
<td>.</td>
</tr>
<tr>
<td></td>
<td>994</td>
<td>3E2000</td>
</tr>
<tr>
<td></td>
<td>993</td>
<td>3E1000</td>
</tr>
<tr>
<td></td>
<td>992</td>
<td>3E0000</td>
</tr>
<tr>
<td>1</td>
<td>31</td>
<td>1F000</td>
</tr>
<tr>
<td></td>
<td>30</td>
<td>1E000</td>
</tr>
<tr>
<td></td>
<td>.</td>
<td>.</td>
</tr>
<tr>
<td></td>
<td>18</td>
<td>12000</td>
</tr>
<tr>
<td></td>
<td>17</td>
<td>11000</td>
</tr>
</tbody>
</table>

continued...
<table>
<thead>
<tr>
<th>Sector</th>
<th>Subsector</th>
<th>Address Range (Byte Addresses in HEX)</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td></td>
<td>Start</td>
</tr>
<tr>
<td>16</td>
<td>1000</td>
<td>10FFF</td>
</tr>
<tr>
<td>0</td>
<td>15</td>
<td>F000</td>
</tr>
<tr>
<td></td>
<td>14</td>
<td>E000</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>2</td>
<td>2000</td>
<td>2FFF</td>
</tr>
<tr>
<td>1</td>
<td>1000</td>
<td>1FFF</td>
</tr>
<tr>
<td>0</td>
<td>H'0000000</td>
<td>H'0000000</td>
</tr>
</tbody>
</table>

**1.6.4. Address Range for EPCQ64A**

**Table 14. Address Range for Sectors 127..0 and Subsectors 2047..0 in EPCQ64A Devices**

<table>
<thead>
<tr>
<th>Sector</th>
<th>Subsector</th>
<th>Address Range (Byte Addresses in HEX)</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td></td>
<td>Start</td>
</tr>
<tr>
<td>127</td>
<td>2047</td>
<td>7FF000</td>
</tr>
<tr>
<td></td>
<td>2046</td>
<td>7FE000</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>64</td>
<td>1039</td>
<td>40F000</td>
</tr>
<tr>
<td></td>
<td>1038</td>
<td>40E000</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>63</td>
<td>1023</td>
<td>3FF000</td>
</tr>
<tr>
<td></td>
<td>1022</td>
<td>3FE000</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>62</td>
<td>1007</td>
<td>3EF000</td>
</tr>
<tr>
<td></td>
<td>1006</td>
<td>3EE000</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

continued...
## 1.6.5. Address Range for EPCQ128A

### Table 15. Address Range for Sectors 255..0 and Subsectors 4095..0 in EPCQ128A Devices

<table>
<thead>
<tr>
<th>Sector</th>
<th>Subsector</th>
<th>Address Range (Byte Addresses in HEX)</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td></td>
<td>Start</td>
</tr>
<tr>
<td>255</td>
<td>4095</td>
<td>FFF000</td>
</tr>
<tr>
<td></td>
<td>4094</td>
<td>FFE000</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>4082</td>
<td>FF2000</td>
</tr>
<tr>
<td></td>
<td>4081</td>
<td>FF1000</td>
</tr>
<tr>
<td></td>
<td>4080</td>
<td>FF0000</td>
</tr>
<tr>
<td>254</td>
<td>4079</td>
<td>FEF000</td>
</tr>
<tr>
<td></td>
<td>4078</td>
<td>FEE000</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>4066</td>
<td>FE2000</td>
</tr>
<tr>
<td></td>
<td>4065</td>
<td>FE1000</td>
</tr>
<tr>
<td></td>
<td>4064</td>
<td>FE0000</td>
</tr>
<tr>
<td>129</td>
<td>2079</td>
<td>81F000</td>
</tr>
</tbody>
</table>

continued...
<table>
<thead>
<tr>
<th>Sector</th>
<th>Subsector</th>
<th>Address Range (Byte Addresses in HEX)</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td></td>
<td>Start</td>
</tr>
<tr>
<td>128</td>
<td></td>
<td>81E000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>812000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>811000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>810000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>80F000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>80E000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>802000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>801000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>800000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>7FF000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>7FE000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>7F2000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>7F1000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>7F0000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>40F000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>40E000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>402000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>401000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>400000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>3FF000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>3FE000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>3F2000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>3F1000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>3F0000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>3EF000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>3EE000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>3E2000</td>
</tr>
<tr>
<td></td>
<td></td>
<td>3E1000</td>
</tr>
</tbody>
</table>

continued...
1.7. Memory Operations

This section describes the operations that you can use to access the memory in EPCQ-A devices. When performing the operation, addresses and data are shifted in and out of the device serially, with the MSB first.

1.7.1. Timing Requirements

When the active low chip select (nCS) signal is driven low, shift in the operation code into the EPCQ-A device using the DATA0 pin. Each operation code bit is latched into the EPCQ-A device at rising edges of the DCLK signal.

While executing an operation, shift in the desired operation code, followed by the address or data bytes. See related information for more information about the address and data bytes. The device must drive the nCS pin high after the last bit of the operation sequence is shifted in.

For read operations, the data read is shifted out on the DATA[3:0] pins. You can drive the nCS pin high when any bit of the data is shifted out.

For write and erase operations, drive the nCS pin high at a byte boundary, that is in a multiple of eight clock pulses. Otherwise, the operation is rejected and not executed.

All attempts to access the memory contents while a write or erase cycle is in progress are rejected, and the write or erase cycle continues unaffected.
### 1.8. Status Register

#### Table 16. Status Register Bits

<table>
<thead>
<tr>
<th>Bit</th>
<th>R/W</th>
<th>Default Value</th>
<th>Name</th>
<th>Value</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>7</td>
<td>R/W</td>
<td>0(5)</td>
<td>Reserve</td>
<td></td>
<td></td>
</tr>
<tr>
<td>6</td>
<td>R/W</td>
<td>0(5)</td>
<td>Reserved</td>
<td></td>
<td></td>
</tr>
<tr>
<td>5</td>
<td>R/W</td>
<td>0</td>
<td>TB (Top/Bottom Bit)</td>
<td></td>
<td>1=Protected area starts from the bottom of the memory array.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>0=Protected area starts from the top of the memory array.</td>
</tr>
<tr>
<td>4</td>
<td>R/W</td>
<td>0</td>
<td>BP2(6)</td>
<td></td>
<td>Table 17 on page 18 through Table 21 on page 20 list the protected area with reference to the block protect bits.</td>
</tr>
<tr>
<td>3</td>
<td>R/W</td>
<td>0</td>
<td>BP1(6)</td>
<td></td>
<td>Determine the area of the memory protected from being written or erased unintentionally.</td>
</tr>
<tr>
<td>2</td>
<td>R/W</td>
<td>0</td>
<td>BP0(6)</td>
<td></td>
<td></td>
</tr>
<tr>
<td>1</td>
<td>R</td>
<td>0</td>
<td>WEL (Write Enable Latch Bit)</td>
<td>1=Allows the following operation to run:</td>
<td>Allows or rejects certain operation to run.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
<td>Write Bytes</td>
<td>Write Status Register</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
<td>Erase Bulk</td>
<td>Erase Sector</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
<td>0=Rejects the above mentioned operations.</td>
<td></td>
</tr>
<tr>
<td>0</td>
<td>R</td>
<td>0</td>
<td>WIP (Write in Progress Bit)</td>
<td>1=One of the following operation is in progress:</td>
<td>Indicates if there is a command in progress.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
<td>Write Status Register</td>
<td>Write Bytes</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
<td>Erase</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
<td>0=no write or erase cycle in progress</td>
<td></td>
</tr>
</tbody>
</table>

#### 1.8.1. Read Status Operation

The status register can be read continuously and at anytime, including during a write or erase operations.

**Figure 4. Read Status Operation Timing Diagram**

---

(5) Do not program these bits to 1.

(6) The erase bulk and erase die operation is only available when all the block protect bits are set to 0. When any of the block protect bits are set to 1, the relevant area is protected from being written by a write bytes operation or erased by an erase sector operation.
### Table 17. Block Protection Bits in EPCQ4A

<table>
<thead>
<tr>
<th>Status Register Content</th>
<th>Memory Content</th>
</tr>
</thead>
<tbody>
<tr>
<td>TB Bit</td>
<td>BP2 Bit</td>
</tr>
<tr>
<td>x</td>
<td>0</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
</tr>
<tr>
<td>x</td>
<td>1</td>
</tr>
</tbody>
</table>

### Table 18. Block Protection Bits in EPCQ16A

<table>
<thead>
<tr>
<th>Status Register Content</th>
<th>Memory Content</th>
</tr>
</thead>
<tbody>
<tr>
<td>TB Bit</td>
<td>BP2 Bit</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
</tr>
</tbody>
</table>

### Table 19. Block Protection Bits in EPCQ32A

<table>
<thead>
<tr>
<th>Status Register Content</th>
<th>Memory Content</th>
</tr>
</thead>
<tbody>
<tr>
<td>TB Bit</td>
<td>BP2 Bit</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
</tr>
</tbody>
</table>

*continued...*
### Table 20. Block Protection Bits in EPCQ64A

<table>
<thead>
<tr>
<th>Status Register Content</th>
<th>Memory Content</th>
</tr>
</thead>
<tbody>
<tr>
<td>TB Bit</td>
<td>BP2 Bit</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
</tr>
<tr>
<td>0</td>
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<tr>
<td>0</td>
<td>1</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
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<td>0</td>
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<td>1</td>
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<td>1</td>
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<td>1</td>
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<td>1</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
</tr>
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<td>1</td>
<td>1</td>
</tr>
</tbody>
</table>
### Table 21. Block Protection Bits in EPCQ128A

<table>
<thead>
<tr>
<th>TB Bit</th>
<th>BP2 Bit</th>
<th>BP1 Bit</th>
<th>BP0 Bit</th>
<th>Protected Area</th>
<th>Unprotected Area</th>
</tr>
</thead>
<tbody>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>None</td>
<td>All sectors</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>Sectors (252 to 255)</td>
<td>Sectors (0 to 251)</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>1</td>
<td>0</td>
<td>Sectors (248 to 255)</td>
<td>Sectors (0 to 247)</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>1</td>
<td>1</td>
<td>Sectors (240 to 255)</td>
<td>Sectors (0 to 239)</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
<td>0</td>
<td>0</td>
<td>Sectors (224 to 255)</td>
<td>Sectors (0 to 223)</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
<td>0</td>
<td>1</td>
<td>Sectors (192 to 255)</td>
<td>Sectors (0 to 191)</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
<td>1</td>
<td>0</td>
<td>Sectors (128 to 255)</td>
<td>Sectors (0 to 127)</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>All sectors</td>
<td>None</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>None</td>
<td>All sectors</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>Sectors (0 to 3)</td>
<td>Sectors (4 to 255)</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
<td>1</td>
<td>0</td>
<td>Sectors (0 to 7)</td>
<td>Sectors (8 to 255)</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
<td>1</td>
<td>1</td>
<td>Sectors (0 to 15)</td>
<td>Sectors (16 to 255)</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>0</td>
<td>0</td>
<td>Sectors (0 to 31)</td>
<td>Sectors (32 to 255)</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>0</td>
<td>1</td>
<td>Sectors (0 to 63)</td>
<td>Sectors (64 to 255)</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>1</td>
<td>0</td>
<td>Sectors (0 to 127)</td>
<td>Sectors (128 to 255)</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>All sectors</td>
<td>None</td>
</tr>
</tbody>
</table>

#### 1.8.2. Write Status Operation

The write status operation does not affect the write enable latch and write in progress bits. You can use the write status operation to set the status register block protection and top or bottom bits. Therefore, you can implement this operation to protect certain memory sectors. After setting the block protect bits, the protected memory sectors are treated as read-only memory. You must execute the write enable operation before the write status operation.

![Write Status Operation Timing Diagram](image)

Immediately after the \( nCS \) signal drives high, the device initiates the self-timed write status cycle. The self-timed write status cycle usually takes \( 10 \text{ ms} \) for all EPCQ-A devices and is guaranteed to be less than \( 15 \text{ ms} \). For details about \( t_{WS} \), refer to the related information below. You must account for this delay to ensure that the status register is written with the desired block protect bits. Alternatively, you can check the
write in progress bit in the status register by executing the read status operation while the self-timed write status cycle is in progress. Write in progress bit is 1 during the self-timed write status cycle and 0 when it is complete.

1.9. Summary of Operation Codes

<table>
<thead>
<tr>
<th>Operation</th>
<th>Operation Code(7)</th>
<th>Address Bytes</th>
<th>Dummy Cycles</th>
<th>Data Bytes</th>
<th>DCLK f_{MAX} (MHz)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Read status</td>
<td>05h</td>
<td>0</td>
<td>0</td>
<td>1 to infinite(8)</td>
<td>100</td>
</tr>
<tr>
<td>Read bytes</td>
<td>03h</td>
<td>3</td>
<td>0</td>
<td>1 to infinite(8)</td>
<td>50</td>
</tr>
<tr>
<td>Read device identification</td>
<td>9Fh</td>
<td>0</td>
<td>2</td>
<td>1</td>
<td>100</td>
</tr>
<tr>
<td>Read silicon identification</td>
<td>ABh</td>
<td>0</td>
<td>3</td>
<td>1</td>
<td>100</td>
</tr>
<tr>
<td>Fast read</td>
<td>0Bh</td>
<td>3</td>
<td>8</td>
<td>1 to infinite(8)</td>
<td>100</td>
</tr>
<tr>
<td>Extended dual input fast read</td>
<td>BBh</td>
<td>3</td>
<td>4</td>
<td>1 to infinite(8)</td>
<td>100</td>
</tr>
<tr>
<td>Extended quad input fast read</td>
<td>EBh</td>
<td>3</td>
<td>6</td>
<td>1 to infinite(8)</td>
<td>100</td>
</tr>
<tr>
<td>Write enable</td>
<td>06h</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>100</td>
</tr>
<tr>
<td>Write disable</td>
<td>04h</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>100</td>
</tr>
<tr>
<td>Write status</td>
<td>01h</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>100</td>
</tr>
<tr>
<td>Write bytes</td>
<td>02h</td>
<td>3</td>
<td>0</td>
<td>1 to 256(10)</td>
<td>100</td>
</tr>
<tr>
<td>Quad input fast write bytes</td>
<td>32h</td>
<td>3</td>
<td>0</td>
<td>1 to 256(10)</td>
<td>100</td>
</tr>
<tr>
<td>Erase bulk</td>
<td>C7h</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>100</td>
</tr>
<tr>
<td>Erase sector</td>
<td>D8h</td>
<td>3</td>
<td>0</td>
<td>0</td>
<td>100</td>
</tr>
<tr>
<td>Erase subsector</td>
<td>20h</td>
<td>3</td>
<td>0</td>
<td>0</td>
<td>100</td>
</tr>
<tr>
<td>Read SFDP register(9)</td>
<td>5Ah</td>
<td>3</td>
<td>8</td>
<td>1 to 256</td>
<td>100</td>
</tr>
</tbody>
</table>

1.9.1. Read Bytes Operation (03h)

When you execute the read bytes operation, you first drive the nCS pin low and shift in the read bytes operation code, followed by a 3-byte address (A[23..0]). Each address bit must be latched in at rising edges of the DCLK signal. After the address is latched in, the memory contents of the specified address are shifted out serially on the DATA1 pin, beginning with the MSB. For reading Raw Programming Data File (.rpd),

(7) List MSB first and LSB last.

(8) The status register or data is read out at least once and is continuously read out until the nCS pin is driven high.

(9) This operation is not applicable for EPCQ4A.

(10) A write bytes operation requires at least one data byte. If more than 256 bytes are sent to the device, only the last 256 bytes are written to the memory.
the content is shifted out serially beginning with the LSB. Each data bit is shifted out at falling edges of the DCLK signal. The maximum DCLK frequency during the read bytes operation is 50 MHz.

Figure 6. Read Bytes Operation Timing Diagram

The first byte address can be at any location. The device automatically increases the address to the next higher address after shifting out each byte of data. Therefore, the device can read the whole memory with a single read bytes operation. When the device reaches the highest address, the address counter restarts at 0x000000, allowing the memory contents to be read out indefinitely until the read bytes operation is terminated by driving the nCS signal high. If the read bytes operation is shifted in while a write or erase cycle is in progress, the operation is not executed and does not affect the write or erase cycle in progress.

1.9.2. Fast Read Operation (0Bh)

When you execute the fast read operation, you first shift in the fast read operation code, followed by a 3-byte address (A[23..0]), and 8 dummy cycles with each bit being latched-in at rising edges of the DCLK signal. Then, the memory contents at that address is shifted out on DATA1 with each bit being shifted out at a maximum frequency of 100 MHz at falling edges of the DCLK signal.

Figure 7. Fast Read Operation Timing Diagram
The first byte address can be at any location. The device automatically increases the address to the next higher address after shifting out each byte of data. Therefore, the device can read the whole memory with a single fast read operation. When the device reaches the highest address, the address counter restarts at 0x000000, allowing the read sequence to continue indefinitely.

You can terminate the fast read operation by driving the nCS signal high at any time during data output. If the fast read operation is shifted in while an erase, program, or write cycle is in progress, the operation is not executed and does not affect the erase, program, or write cycle in progress.

**1.9.3. Extended Dual Input Fast Read Operation (BBh)**

This operation is similar to the fast read operation except that the data and addresses are shifted in and out on the DATA0 and DATA1 pins.

**Figure 8. Extended Dual Input Fast Read Operation Timing Diagram**

![Timing Diagram](image)

**1.9.4. Extended Quad Input Fast Read Operation (EBh)**

This operation is similar to the extended dual input fast read operation except that the data and addresses are shifted in and out on the DATA0, DATA1, DATA2, and DATA3 pins.
1.9.5. Read Device Identification Operation (9Fh)

This operation reads the 8-bit device identification of the EPCQ-A device from the DATA1 output pin. If this operation is shifted in while an erase or write cycle is in progress, the operation is not executed and does not affect the erase or write cycle in progress.

Table 22. EPCQ-A Device Identification

<table>
<thead>
<tr>
<th>EPCQ-A Device</th>
<th>Device ID (Binary Value)</th>
</tr>
</thead>
<tbody>
<tr>
<td>EPCQ4A</td>
<td>b'0001 0011</td>
</tr>
<tr>
<td>EPCQ16A</td>
<td>b'0001 0101</td>
</tr>
<tr>
<td>EPCQ32A</td>
<td>b'0001 0110</td>
</tr>
<tr>
<td>EPCQ64A</td>
<td>b'0001 0111</td>
</tr>
<tr>
<td>EPCQ128A</td>
<td>b'0001 1000</td>
</tr>
</tbody>
</table>

The 8-bit device identification of the EPCQ-A device is shifted out on the DATA1 pin at falling edges of the DCLK signal.

1.9.6. Read Silicon Identification Operation (ABh)

This operation reads the 8-bit silicon ID of the EPCQ-A device from the DATA1 output pin. If this operation is shifted in during an erase or write cycle, it is ignored and does not affect the cycle that is in progress.
Note: This operation is applicable to EPCQ4A, EPCQ16A and EPCQ64A devices only.

The device implements the read silicon ID operation by driving the nCS signal low and then shifting in the read silicon ID operation code, followed by three dummy bytes on the DATA0 pin. The 8-bit silicon ID of the EPCQ-A device is then shifted out on the DATA1 pin at falling edges of the DCLK signal. The device can terminate the read silicon ID operation by driving the nCS signal high after reading the silicon ID at least one time. Sending additional clock cycles on DCLK while nCS is driven low can cause the silicon ID to be shifted out repeatedly.

Table 23. EPCQ-A Silicon Identification

<table>
<thead>
<tr>
<th>EPCQ-A Device</th>
<th>Silicon ID (Binary Value)</th>
</tr>
</thead>
<tbody>
<tr>
<td>EPCQ4A</td>
<td>b'0001 0010</td>
</tr>
<tr>
<td>EPCQ16A</td>
<td>b'0001 0100</td>
</tr>
<tr>
<td>EPCQ64A</td>
<td>b'0001 0110</td>
</tr>
</tbody>
</table>

Figure 11. Read Silicon Identification Operation Timing Diagram

1.9.7. Write Enable Operation (06h)

When you enable the write enable operation, the write enable latch bit is set to 1 in the status register. You must execute this operation before the write bytes, write status, erase bulk, erase sector, and quad input fast write bytes operations.

Figure 12. Write Enable Operation Timing Diagram
1.9.8. Write Disable Operation (04h)

The write disable operation resets the write enable latch bit in the status register. To prevent the memory from being written unintentionally, the write enable latch bit is automatically reset when implementing the write disable operation, and under the following conditions:

- Power up
- Write bytes operation completion
- Write status operation completion
- Erase bulk operation completion
- Erase sector operation completion
- Quad input fast write bytes operation completion

![Write Disable Operation Timing Diagram](image1)

1.9.9. Write Bytes Operation (02h)

This operation allows bytes to be written to the memory. You must execute the write enable operation before the write bytes operation. After the write bytes operation is completed, the write enable latch bit in the status register is set to 0.

When you execute the write bytes operation, you shift in the write bytes operation code, followed by a 3-byte address (A[23..0]) and at least one data byte on the DATA0 pin. If the eight LSBs (A[7..0]) are not all 0, all sent data that goes beyond the end of the current page is not written into the next page. Instead, this data is written at the start address of the same page. You must ensure the nCS signal is set low during the entire write bytes operation.

![Write Bytes Operation Timing Diagram](image2)
If more than 256 data bytes are shifted into the EPCQ-A device with a write bytes operation, the previously latched data is discarded and the last 256 bytes are written to the page. However, if less than 256 data bytes are shifted into the EPCQ-A device, they are guaranteed to be written at the specified addresses and the other bytes of the same page are not affected.

The device initiates a self-timed write cycle immediately after the nCS signal is driven high. For details about the self-timed write cycle time, refer to $t_{WB}$ in the related information below. You must account for this amount of delay before another page of memory is written. Alternatively, you can check the write in progress bit in the status register by executing the read status operation while the self-timed write cycle is in progress. The write in progress bit is set to 1 during the self-timed write cycle and 0 when it is complete.

**Note:**
You must erase all the memory bytes of EPCQ-A devices before you implement the write bytes operation. You can erase all the memory bytes by executing the erase sector operation in a sector or the erase bulk operation throughout the entire memory.

1.9.10. Quad Input Fast Write Bytes Operation (32h)

This operation is similar to the write bytes operation except that the data are shifted in on the DATA0, DATA1, DATA2, and DATA3 pins.

**Figure 15. Quad Input Fast Write Bytes Operation Timing Diagram**

1.9.11. Erase Bulk Operation (C7h)

This operation sets all the memory bits to 1 or 0xFF. Similar to the write bytes operation, you must execute the write enable operation before the erase bulk operation.

You can implement the erase bulk operation by driving the nCS signal low and then shifting in the erase bulk operation code on the DATA0 pin. The nCS signal must be driven high after the eighth bit of the erase bulk operation code has been latched in.
Figure 16. Erase Bulk Operation Timing Diagram

The device initiates a self-timed erase bulk cycle immediately after the nCS signal is driven high. For details about the self-timed erase bulk cycle time, refer to t_{EB} in the related information below.

You must account for this delay before accessing the memory contents. Alternatively, you can check the write in progress bit in the status register by executing the read status operation while the self-timed erase cycle is in progress. The write in progress bit is set to 1 during the self-timed erase cycle and 0 when it is complete. The write enable latch bit in the status register is reset to 0 before the erase cycle is complete.

1.9.12. Erase Sector Operation (D8h)

The erase sector operation allows you to erase a certain sector in the EPCQ-A device by setting all the bits inside the sector to 1 or 0xFF. This operation is useful if you want to access the unused sectors as a general purpose memory in your applications. You must execute the write enable operation before the erase sector operation.

When you execute the erase sector operation, you must first shift in the erase sector operation code, followed by the 3-byte address (A_{23..0}) of the chosen sector on the DATA0 pin. The 3-byte address for the erase sector operation can be any address inside the specified sector. Drive the nCS signal high after the eighth bit of the erase sector operation code has been latched in.

Figure 17. Erase Sector Operation Timing Diagram

The device initiates a self-timed erase sector cycle immediately after the nCS signal is driven high. For details about the self-timed erase sector cycle time, refer to t_{ES} in the related information below. You must account for this amount of delay before another page of memory is written. Alternatively, you can check the write in progress bit in the status register by executing the read status operation while the self-timed erase cycle is in progress. The write in progress bit is set to 1 during the self-timed erase cycle and 0 when it is complete. The write enable latch bit in the status register is set to 0 before the self-timed erase cycle is complete.
1.9.13. Erase Subsector Operation (20h)

The erase subsector operation allows you to erase a certain subsector in the EPCQ-A device by setting all the bits inside the subsector to 1 or 0xFF. This operation is useful if you want to access the unused subsectors as a general purpose memory in your applications. You must execute the write enable operation before the erase subsector operation.

When you execute the erase subsector operation, you must first shift in the erase subsector operation code, followed by the 3-byte address ($A_{23..0}$) of the chosen subsector on the DATA0 pin. The 3-byte address for the erase subsector operation can be any address inside the specified subsector. For details about the subsector address range, refer to the related information below. Drive the nCS signal high after the eighth bit of the erase subsector operation code has been latched in.

**Figure 18. Erase Subsector Operation Timing Diagram**

The device initiates a self-timed erase subsector cycle immediately after the nCS signal is driven high. For details about the self-timed erase subsector cycle time, refer to related the information below. You must account for this amount of delay before another page of memory is written. Alternatively, you can check the write in progress bit in the status register by executing the read status operation while the self-timed erase cycle is in progress. The write in progress bit is set to 1 during the self-timed erase cycle and 0 when it is complete. The write enable latch bit in the status register is set to 0 before the self-timed erase cycle is complete.

1.9.14. Read SFDP Register Operation (5Ah)

The 256-byte SFDP register contains information about device configurations, available operations and other features.

The Read SFDP Register operation is compatible with the JEDEC SFDP standard, JESD216A. For SFDP register values and descriptions, please refer to **Appendix: SFDP Register Definitions** on page 34.
Initiate the Read SFDP operation by driving the \( nCS \) pin low and shifting the operations code followed by a 3-byte address into the \( DATA0 \) pin. The 3-byte address content:

- \( A[23..8] = 0 \)
- \( A[7..0] = \) Defines the starting byte address for the 256-byte SFDP register

Eight dummy cycles are required before the SFDP register contents are shifted out on the falling edge of the 40th \( DCLK \) with the most significant bit (MSB) first.

**Related Information**

Appendix: SFDP Register Definitions on page 34

### 1.10. Power Mode

EPCQ-A devices support active and standby power modes. When the \( nCS \) signal is low, the device is enabled and is in active power mode. The FPGA is configured while the EPCQ-A device is in active power mode. When the \( nCS \) signal is high, the device is disabled but remains in active power mode until all internal cycles are completed, such as write or erase operations. The EPCQ-A device then goes into standby power mode. The \( I_{CC1} \) and \( I_{CC0} \) parameters list the \( V_{CC} \) supply current when the device is in active and standby power modes.
1.11. Timing Information

1.11.1. Write Operation Timing

Figure 20. Write Operation Timing Diagram

Table 24. Write Operation Parameters

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Min</th>
<th>Typical</th>
<th>Max</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>( t_{WCLK} )</td>
<td>Write clock frequency (from the FPGA, download cable, or embedded processor) for write enable, write disable, read status, read device identification, write bytes, erase bulk, and erase sector operations.</td>
<td>—</td>
<td>—</td>
<td>100</td>
<td>MHz</td>
</tr>
<tr>
<td>( t_{CH} )</td>
<td>DCLK high time for EPCQ4A.</td>
<td>4</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td></td>
<td>DCLK high time for EPCQ16A, EPCQ32A, EPCQ64A, and EPCQ128A.</td>
<td>3.4</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{CL} )</td>
<td>DCLK low time for EPCQ4A.</td>
<td>4</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td></td>
<td>DCLK low time for EPCQ16A, EPCQ32A, EPCQ64A, and EPCQ128A.</td>
<td>3.4</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{NCSU} )</td>
<td>Chip select (nCS) active setup time for EPCQ4A.</td>
<td>5</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td></td>
<td>Chip select (nCS) active setup time for EPCQ16A, EPCQ32A, EPCQ64A, and EPCQ128A.</td>
<td>3</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{NCSH} )</td>
<td>Chip select (nCS) not active hold time for EPCQ4A.</td>
<td>5</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td></td>
<td>Chip select (nCS) not active hold time for EPCQ16A, EPCQ32A, EPCQ64A, and EPCQ128A.</td>
<td>3</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{NCSU2} )</td>
<td>Chip select (nCS) not active setup time for EPCQ4A.</td>
<td>5</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td></td>
<td>Chip select (nCS) not active setup time for EPCQ16A, EPCQ32A, EPCQ64A, and EPCQ128A.</td>
<td>3</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{NCSH2} )</td>
<td>Chip select (nCS) active hold time for EPCQ4A.</td>
<td>5</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td></td>
<td>Chip select (nCS) active hold time for EPCQ16A, EPCQ32A, EPCQ64A, and EPCQ128A.</td>
<td>3</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{DSU} )</td>
<td>DATA[ ] in setup time before the rising edge on DCLK</td>
<td>2</td>
<td>—</td>
<td>—</td>
<td>ns</td>
</tr>
</tbody>
</table>

continued...
### 1.11.2. Read Operation Timing

**Figure 21. Read Operation Timing Diagram**

![Read Operation Timing Diagram](image)

---

(11) 10 ns for read and 50 ns for write, erase or program.

(12) The Write Operation Timing Diagram does not show these parameters.

(13) The \( t_{WB} \) parameter is for a complete page write operation.
Table 25.  Read Operation Parameters

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Min</th>
<th>Max</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>( f_{RCLK} )</td>
<td>Read clock frequency (from the FPGA or embedded processor) for read bytes operations</td>
<td>—</td>
<td>50</td>
<td>MHz</td>
</tr>
<tr>
<td></td>
<td>Fast read clock frequency (from the FPGA or embedded processor) for fast read bytes operation</td>
<td>—</td>
<td>100</td>
<td>MHz</td>
</tr>
<tr>
<td>( t_{CH} )</td>
<td>DCLK high time for EPCQ4A.</td>
<td>4 or 6(^{(14)})</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td></td>
<td>DCLK high time for EPCQ16A, EPCQ32A, EPCQ64A, and EPCQ128A.</td>
<td>3.4 or 9(^{(15)})</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{CL} )</td>
<td>DCLK low time for EPCQ4A.</td>
<td>4 or 6(^{(14)})</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td></td>
<td>DCLK low time for EPCQ16A, EPCQ32A, EPCQ64A, and EPCQ128A.</td>
<td>3.4 or 9(^{(15)})</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{ODIS} )</td>
<td>Output disable time after read</td>
<td>—</td>
<td>7</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{CLQV} )</td>
<td>Clock low to output valid for EPCQ4A.</td>
<td>—</td>
<td>8</td>
<td>ns</td>
</tr>
<tr>
<td></td>
<td>Clock low to output valid for EPCQ16A, EPCQ32A, EPCQ64A, and EPCQ128A.</td>
<td>—</td>
<td>6</td>
<td></td>
</tr>
<tr>
<td>( t_{CLQX} )</td>
<td>Output hold time for EPCQ4A.</td>
<td>0</td>
<td>—</td>
<td>ns</td>
</tr>
<tr>
<td></td>
<td>Output hold time for EPCQ16A, EPCQ32A, EPCQ64A, and EPCQ128A.</td>
<td>1.5</td>
<td>—</td>
<td></td>
</tr>
</tbody>
</table>

1.12. Programming and Configuration File Support

The Intel Quartus® Prime software provides programming support for EPCQ-A devices. When you select an EPCQ-A device, the Intel Quartus Prime software automatically generates the Programmer Object File (.pof) to program the device. The software allows you to select the appropriate EPCQ-A device density that most efficiently stores the configuration data for the selected FPGA.

You can program the EPCQ-A device in-system by an external microprocessor using the SRunner software driver. The SRunner software driver is developed for embedded EPCQ-A device programming that you can customize to fit in different embedded systems. The SRunner software driver reads .rpd files and writes to the EPCQ-A devices. The programming time is comparable to the Intel Quartus Prime software programming time. Because the FPGA reads the LSB of the .rpd data first during the configuration process, the LSB of .rpd bytes must be shifted out first during the read bytes operation and shifted in first during the write bytes operation.

Writing and reading the .rpd file to and from the EPCQ-A device is different from the other data and address bytes.

During the ISP of an EPCQ-A device using the Intel FPGA download cables, the cable pulls the nCONFIG signal low to reset the FPGA and overrides the 10-kΩ pull-down resistor on the nCE pin of the FPGA. The download cable then uses the interface pins depending on the selected AS mode to program the EPCQ-A device. When

\[^{(14)}\] 4 ns for fast read and 6 ns for read.

\[^{(15)}\] 3.4 ns for fast read and 9 ns for read.
programming is complete, the download cable releases the interface pins of the EPCQ-A device and the nCE pin of the FPGA and pulses the nCONFIG signal to start the configuration process.

The FPGA can program the EPCQ-A device in-system using the JTAG interface with the serial flash loader (SFL). This solution allows you to indirectly program the EPCQ-A device using the same JTAG interface that is used to configure the FPGA.

**Related Information**

Using the Intel FPGA Serial Flash Loader IP Core with the Intel Quartus Prime Software

### 1.13. Appendix: SDFP Register Definitions

<table>
<thead>
<tr>
<th>Address</th>
<th>EPCQ16A</th>
<th>EPCQ32A</th>
<th>EPCQ64A</th>
<th>EPCQ128A</th>
</tr>
</thead>
<tbody>
<tr>
<td>00H</td>
<td>53h</td>
<td>53h</td>
<td>53h</td>
<td>53h</td>
</tr>
<tr>
<td>01H</td>
<td>46h</td>
<td>46h</td>
<td>46h</td>
<td>46h</td>
</tr>
<tr>
<td>02H</td>
<td>44h</td>
<td>44h</td>
<td>44h</td>
<td>44h</td>
</tr>
<tr>
<td>03H</td>
<td>50h</td>
<td>50h</td>
<td>50h</td>
<td>50h</td>
</tr>
<tr>
<td>04H</td>
<td>05h</td>
<td>05h</td>
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<td>05H</td>
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<td>06H</td>
<td>00h</td>
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<td>07H</td>
<td>FFh</td>
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<td>FFh</td>
</tr>
<tr>
<td>08H</td>
<td>00h</td>
<td>00h</td>
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### Related Information

Read SFDPR Register Operation (5Ah) on page 29


#### Document Version

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<td>2019.03.18</td>
<td>Updated the note 4 in the Supported Memory Array Organization in EPCQ-A Devices table.</td>
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| 2019.01.09       | • Added $t_{NCSSU}$ and $t_{NCSSH}$ parameters in the Write Operation Parameters table.  
        • Updated the $t_{NCSSU}$ and $t_{NCSSH}$ values in the Write Operation Parameters table.  
        • Updated the Write Operation Timing Diagram. |
| 2018.10.04       | Updated the DCLK value in the Extended Dual Input Fast Read Operation Timing Diagram. |

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## Changes

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| 2018.04.11       | • Updated EPCQA instances to EPCQ-A.  
|                  | • Added SFDP register operation code, description, timing diagram, and register definitions.  
|                  | • Added a note stating that $t_{WB}$ is the time for a complete page write in *Write Operation Parameters*.  
|                  | • Removed a note in *Summary of Operation Codes* table stating that Read silicon identification command is not applicable to EPCQ32A and EPCQ128A. |
| 2018.03.13       | • Removed $I_{MAX}$ and $T_{AMB}$ parameters from the *Absolute Maximum Ratings for EPCQ-A Devices* table. |
| 2018.02.15       | • Added $I_{MAX}$ and $T_{AMB}$ parameters in the *Absolute Maximum Ratings for EPCQ-A Devices* table.  
|                  | • Added data retention feature information. |

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| December 2017    | 2017.12.15 | • Updated maximum $t_{DD0S}$ in the *Read Operation Parameters* table.  
|                  |         | • Removed $t_{CLK2D}$ from *Read Operation Parameters* table. |
| August 2017      | 2017.08.02 | • Updated ordering code number.  
|                  |         | • Added link to AN822: *Configuration Device Migration Guideline*.  
|                  |         | • Updated Extended Quad Input Fast Read and Quad Input Fast Write operations timing diagram. |